

Application/Control No.	Applicant(s)/Patent under Reexamination
10/625,792	MANDRO ET AL.
Examiner	Art Unit
Patrick J. Lee	2878

SEARCHED					
Class	Subclass	Date	Examiner		
250	221, 222.1, 231.1, 231.13	12/23/2005	PL		
250	231.14	12/23/2005	PL		
250	231.18	12/23/2005	PL		
341	13, 141	12/23/2006	PL		
Updated	search	5/30/2006	PL		
Updated	search	9/21/2006	PL		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	Subclass	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	12/23/2005	PL			
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	5/30/2006	PL			
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	9/21/2006	PL			
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